Self-Protected Low Side Driver with Temperature and Current Limit

NCV8401A/B is a three terminal protected Low-Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain-to-Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

Features

- Short Circuit Protection
- Thermal Shutdown with Automatic Restart
- Over Voltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial

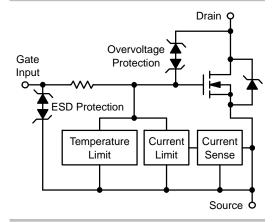


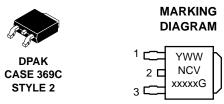
ON Semiconductor®

www.onsemi.com

V _{DSS} (Clamped)	R _{DS(ON)} TYP	I _D MAX (Limited)
42 V	23 mΩ @ 10 V	33 A*

*Max current may be limited below this value depending on input conditions.





Y = Year

WW = Work Week 1 = Gate xxxxx = 8401A or 8401B 2 = Drain G = Pb-Free Package 3 = Source

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV8401ADTRKG	DPAK (Pb-Free)	2500/Tape & Reel
NCV8401BDTRKG	DPAK (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Rating		Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped		V _{DSS}	42	V
Drain-to-Gate Voltage Internally Clamped	$(R_{GS} = 1.0 M\Omega)$	V_{DGR}	42	V
Gate-to-Source Voltage		V _{GS}	±14	V
Drain Current – Continuous		I _D	Internally Limited	
Total Power Dissipation @ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2)		P _D	1.1 2.0	W
Thermal Resistance, Junction-to-Case Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2)		$egin{array}{l} R_{ hetaJC} \ R_{ hetaJA} \ R_{ hetaJA} \end{array}$	1.6 110 60	°C/W
Single Pulse Drain–to–Source Avalanche Energy $(V_{DD}=25~Vdc,~V_{GS}=5.0~Vdc,~I_{L}=3.65~Apk,~L=120~mH,~R_{G}=25~\Omega)$	2, T _{Jstart} = 150°C) (Note 3)	E _{AS}	800	mJ
Load Dump Voltage (V _{GS} = 0 and 10 V, R _I = 2.0 Ω , R _L = 3.0 Ω , t _d = 40	00 ms)	V_{LD}	65	V
Operating Junction Temperature	TJ	-40 to 150	°C	
Storage Temperature	T _{stg}	-55 to 150	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Minimum FR4 PCB, steady state.

- 2. Mounted onto a 2" square FR4 board (1" square, 2 oz. Cu 0.06" thick single–sided, t = steady state).
- 3. Not subject to production testing.

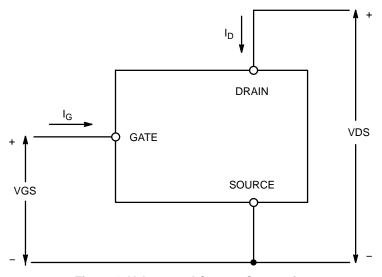


Figure 1. Voltage and Current Convention

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Characte	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Drain-to-Source Clamped Breakdown Vo (V _{GS} = 0 Vdc, I _D = 250 μ Adc) (V _{GS} = 0 Vdc, I _D = 250 μ Adc, T _o	V _{(BR)DSS}	42 42	46 44	50 50	Vdc	
Zero Gate Voltage Drain Current $(V_{DS} = 32 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 32 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J})$	I _{DSS}		1.5 6.5	5.0	μAdc	
Gate Input Current ($V_{GS} = 5.0 \text{ Vdc}, V_{DS} = 0 \text{ Vdc}$)		I _{GSSF}		50	100	μAdc
ON CHARACTERISTICS						
	ent	V _{GS(th)}	1.0	1.8 5.0	2.0	Vdc -mV/°C
Static Drain-to-Source On-Resistance (N $_{GS}$ = 10 Vdc, I $_{D}$ = 5.0 Adc, T $_{J}$ (V $_{GS}$ = 10 Vdc, I $_{D}$ = 5.0 Adc, T $_{J}$	@ 25°C)	R _{DS(on)}		23 43	29 55	mΩ
Static Drain-to-Source On-Resistance (N $_{GS}$ = 5.0 Vdc, I $_{D}$ = 5.0 Adc, T $_{CS}$ (V $_{GS}$ = 5.0 Vdc, I $_{D}$ = 5.0 Adc, T $_{CS}$	R _{DS(on)}		28 50	34 60	mΩ	
Source–Drain Forward On Voltage (I _S = 5 A, V _{GS} = 0 V)	V _{SD}		0.80	1.1	V	
SWITCHING CHARACTERISTICS (Note	4)	•	•	•	•	•
Turn-ON Time (10% V _{IN} to 90% I _D)	V _{IN} = 0 V to 5 V, V _{DD} = 25 V	t _{ON}		41	50	μs
Turn-OFF Time (90% V _{IN} to 10% I _D)	$I_D = 1.0 \text{ A}, \text{ Ext R}_G = 2.5 \Omega$	t _{OFF}		129	150	
Turn-ON Time (10% V _{IN} to 90% I _D)	V _{IN} = 0 V to 10 V, V _{DD} = 25 V	t _{ON}		16	25	
Turn-OFF Time (90% V _{IN} to 10% I _D)	$I_D = 1.0 \text{ A, Ext R}_G = 2.5 \Omega$	t _{OFF}		164	180	
Slew-Rate ON (80% V _{DS} to 50% V _{DS})	V_{in} = 0 to 10 V, V_{DD} = 12 V, R_L = 4.7 Ω	-dV _{DS} /dt _{ON}		1.27	2.0	V/μs
Slew–Rate OFF (50% V_{DS} to 80% V_{DS})	$R_L = 4.7 \Omega$	dV _{DS} /dt _{OFF}		0.36	0.75	
SELF PROTECTION CHARACTERISTIC	S ($T_J = 25^{\circ}C$ unless otherwise noted)					
Current Limit	$V_{GS} = 5.0 \text{ V}, V_{DS} = 10 \text{ V}$ $V_{GS} = 5.0 \text{ V}, T_J = 150^{\circ}\text{C} \text{ (Note 4)}$	I _{LIM}	25 11	30 16	35 21	Adc
	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ $V_{GS} = 10 \text{ V}, T_J = 150^{\circ}\text{C} \text{ (Note 4)}$		30 18	35 25	40 28	
Temperature Limit (Turn-off)	$V_{GS} = 5.0 \text{ V (Note 4)}$	T _{LIM(off)}	150	175	200	°C
Thermal Hysteresis	V _{GS} = 5.0 V	$\Delta T_{LIM(on)}$		15		°C
Temperature Limit (Turn-off)	V _{GS} = 10 V (Note 4)	$T_{LIM(off)}$	150	165	185	°C
Thermal Hysteresis	V _{GS} = 10 V	$\Delta T_{LIM(on)}$		15		°C
GATE INPUT CHARACTERISTICS (Note	<u>'</u>		1		1	1
Device ON Gate Input Current	$V_{GS} = 5 V I_D = 1.0 A$	I _{GON}		50	100	μΑ
	$V_{GS} = 10 \text{ V } I_D = 1.0 \text{ A}$			400	700	
Current Limit Gate Input Current	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$	I _{GCL}		0.1	0.5	mA
	V _{GS} = 10 V, V _{DS} = 10 V			0.7	1.0	
Thermal Limit Fault Gate Input Current	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$	I _{GTL}		0.6	1.0	mA
	V _{GS} = 10 V, V _{DS} = 10 V			2.0	4.0	
ESD ELECTRICAL CHARACTERISTICS	$(T_J = 25^{\circ}C \text{ unless otherwise noted}) (N_J = 25^{\circ}C \text{ unless otherwise noted})$	1	1		1	
Electro-Static Discharge Capability Human Body Model (HBM) Machine Model (MM)		ESD	4000 400			V

^{4.} Not subject to production testing.
5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

TYPICAL PERFORMANCE CURVES

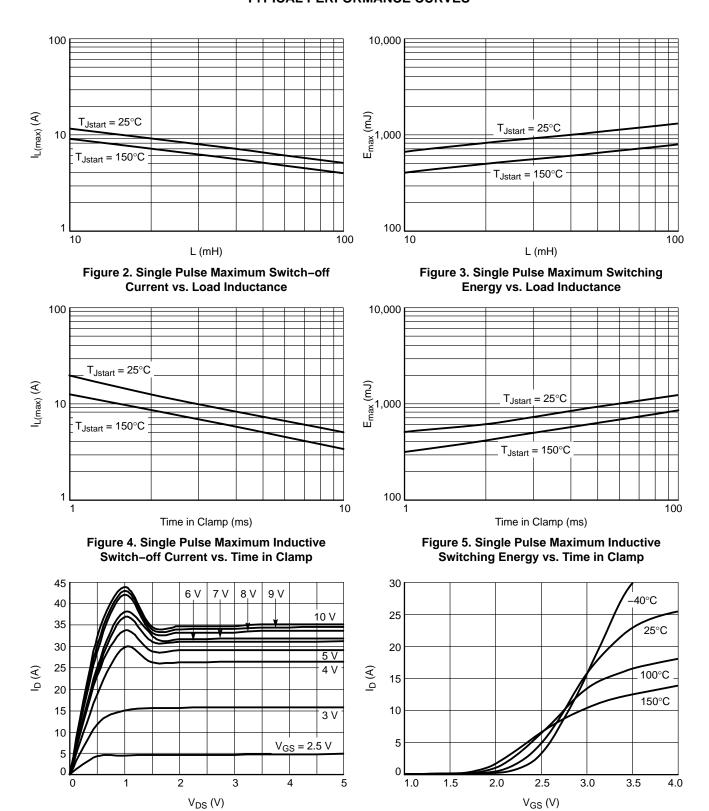


Figure 6. On-state Output Characteristics at 25°C

Figure 7. Transfer Characteristics (V_{DS} = 10 V)

TYPICAL PERFORMANCE CURVES

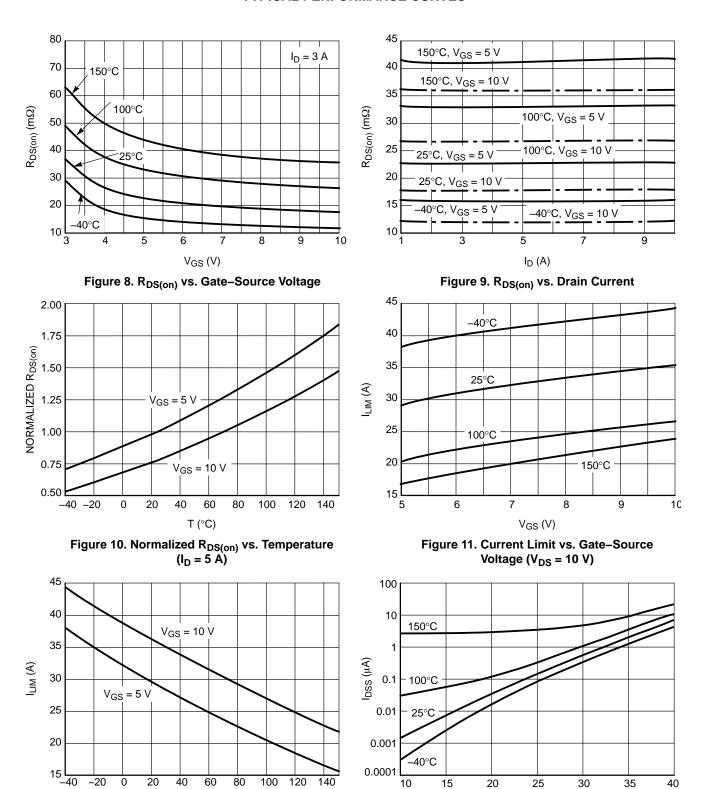


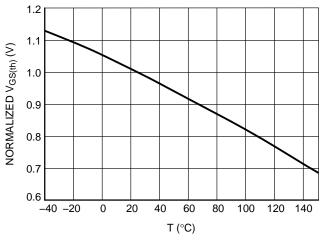
Figure 12. Current Limit vs. Junction Temperature (V_{DS} = 10 V)

T_J (°C)

Figure 13. Drain-to-Source Leakage Current (V_{GS} = 0 V)

 $V_{DS}(V)$

TYPICAL PERFORMANCE CURVES



1.0 0.9 -40°C 8.0 25°C $V_{SD}(V)$ 0.7 100°C 0.6 150°C 0.5 0.4 2 5 6 8 9 10 3 4 I_S (A)

Figure 14. Normalized Threshold Voltage vs. Temperature ($I_D = 1.2 \text{ mA}, V_{DS} = V_{GS}$)

200

150

100

50

3

TIME (µs)

t_d(off)

t_f

t_r

9 10

Figure 15. Source–Drain Diode Forward Characteristics (V_{GS} = 0 V)

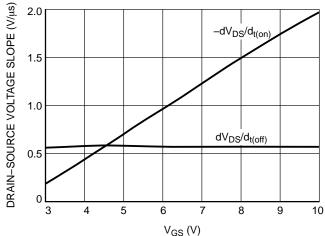


Figure 16. Resistive Load Switching Time vs. Gate–Source Voltage $(V_{DD} = 25 \text{ V}, I_D = 5 \text{ A}, R_G = 0 \Omega)$

V_{GS} (V)

6

5

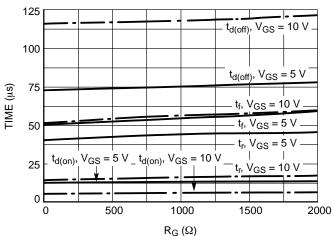


Figure 17. Resistive Load Switching Drain–Source Voltage Slope vs. Gate–Source Voltage (V_{DD} = 25 V, I_{D} = 5 A, R_{G} = 0 Ω)

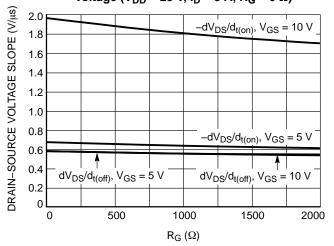


Figure 18. Resistive Load Switching Time vs. Gate Resistance ($V_{DD} = 25 \text{ V}$, $I_D = 5 \text{ A}$)

Figure 19. Drain–Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance ($V_{DD} = 25 \text{ V}, I_D = 5 \text{ A}$)

TYPICAL PERFORMANCE CURVES

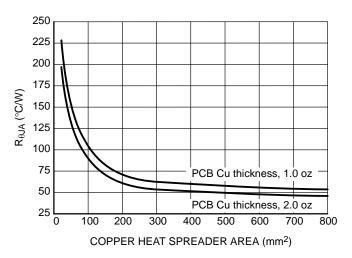


Figure 20. $R_{\theta JA}$ vs. Copper Area

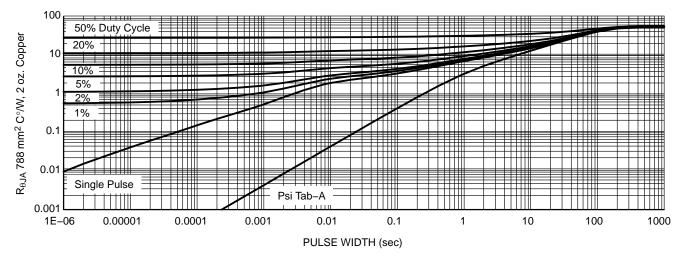


Figure 21. Transient Thermal Resistance

TEST CIRCUITS AND WAVEFORMS

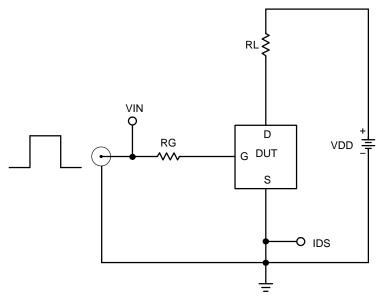


Figure 22. Resistive Load Switching Test Circuit

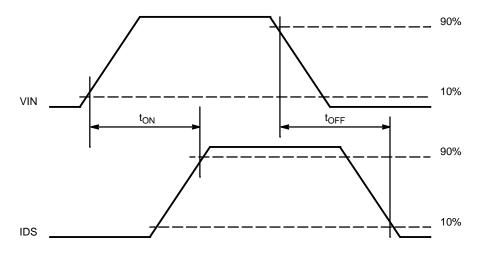


Figure 23. Resistive Load Switching Waveforms

TEST CIRCUITS AND WAVEFORMS

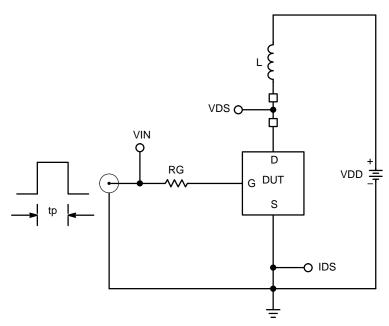


Figure 24. Inductive Load Switching Test Circuit

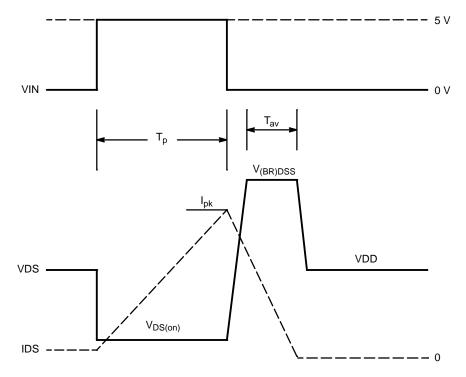
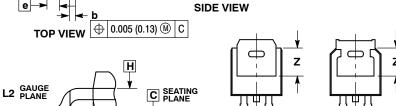


Figure 25. Inductive Load Switching Waveforms



DPAK (SINGLE GAUGE) CASE 369C **ISSUE F** SCALE 1:1 Α <-b3 В L3 Z ۩ **DETAIL A**



C-

Α1 **DETAIL A** ROTATED 90° CW

STYLE 2:

NOTE 7

h2

STYLE 1:



STYLE 4:

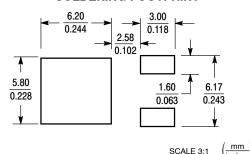
BOTTOM VIEW

STYLE 5:

OTTLL I.	OTTLL 2.	011	LL U.	O i	ILL T.	OTTLE J.
PIN 1. BASE	PIN 1. GA	TE PI	N 1. ANODE	P	IN 1. CATHODE	PIN 1. GATE
2. COLLEC	CTOR 2. DR	AIN	CATHOD	DΕ	ANODE	2. ANODE
EMITTE	R 3. SO	URCE	ANODE		GATE	CATHODE
4. COLLEC	CTOR 4. DR	AIN	4. CATHOD	DΕ	ANODE	ANODE
STYLE 6:	STYLE 7:	STYLE 8:	,	STYLE 9:		STYLE 10:
PIN 1. MT1	PIN 1. GATE	PIN 1. N/	С	PIN 1. AN	NODE	PIN 1. CATHODE
2. MT2	COLLECTOR	R 2. C/	ATHODE	2. C/	ATHODE	ANODE
GATE	EMITTER	3. AN	NODE	3. RI	ESISTOR ADJUST	CATHODE
4. MT2	 COLLECTOR 	R 4. CA	ATHODE	4. C/	ATHODE	4. ANODE

STYLE 3:

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DATE 21 JUL 2015

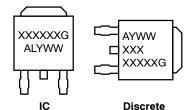
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
œ	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114	REF	2.90	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

GENERIC MARKING DIAGRAM*



XXXXXX = Device Code = Assembly Location Α L = Wafer Lot Υ = Year

WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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